Notice of References Cited Application/Control No. 10/053,433 Examiner Alan S Chen Applicant(s)/Patent Under Reexamination SCOTT ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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	U	The Authoritative Dictionary of IEEE Standards Terms; 2000; IEEE Press; Seventh Edition; page 298
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